IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

atent A	pplica	ation of:			
Jung PA	ARK,	et al.			
Application No.: Unassigned			Group Art Unit: Unassigned		
June 27	7, 200	03	Examiner: Unassigned		
For: METHOD OF PROVIDING ANTIBACTERIA NANO-SIZED METAL PARTICLES			L ACTIVITY ON A SURFACE OF A BODY USING		
		INFORMATION DISCI	LOSURE STATEMENT		
x 1450					
informa applica	ation tion.	which the Examiner may conside It is requested that the Examine	ovisions of 37 CFR § 1.56, there is hereby provided er material to the examination of the subject U.S. r make this information of record if it is deemed n.		
1.	Encl	osures accompanying this Inforn	nation Disclosure Statement are:		
1b. 1c. 1d.		or a PCT International Search F English language translation (A language publication. Explanations of Relevancy of R	earch report(s) from a counterpart foreign application Report. bstract Only) attached to each non-English references (ATTACHMENT 1(e), hereto) for n of each non-English publication.		
2. 🛛			a concise explanation of what is presently ach non-English language publication is		
		"English-language version of the of relevance found by the foreign for an Information Disclosure Strelevance, pp. 600-100 to 600-	sh language publications were cited on the enclosed e search report or action which indicates the degree on office". (See MPEP 609, Minimum Requirements tatement, Part A(3): Concise Explanation of		
	Jung PA ation No June 2: METH NANO issioner x 1450 idria, VA In accordinforma applica al to the 1. 1a. 1b. 1c. 1d. 1e. 2. 2a.	Jung PARK, ation No.: Ur June 27, 200 METHOD C NANO-SIZE issioner for I x 1450 adria, VA 223 In accordan information application. al to the exar 1. Encl 1a. 1b. 1c. 1d. 1e. 1	METHOD OF PROVIDING ANTIBACTERIANANO-SIZED METAL PARTICLES INFORMATION DISCI issioner for Patents x 1450 dria, VA 22313-1450 In accordance with the duty of disclosure provinformation which the Examiner may conside application. It is requested that the Examine at to the examination of the subject application. 1. Enclosures accompanying this Inform 1a. Form PTO-1449. 1b. Copies of IDS citations. 1c. An English language copy of secondary and a PCT International Search Form PTO-1449. 1d. English language translation (A language publication. 1e. Explanations of Relevancy of Reproviding a concise explanation 2. In accordance with 37 CFR § 1.98, a understood to be the relevance of explanation of the relevance of the providing and providing a concise explanation of relevance found by the foreign and information Disclosure Selevance, pp. 600-100 to 600-		

2c. 🔯 satisfied because an English language translation (Abstract Only) is attached to each non-English language publication. enclosed as Attachment 1(e), hereto. 2d. \square 3. No admission is made that the information cited in this Statement is, or is considered to be, material to patentability nor a representation that a search has been made (other than search report(s) from a counterpart foreign application or a PCT International Search Report, if submitted herewith). 37 CFR §§ 1.97(g) and (h). Respectfully submitted,

STAAS & HALSEY LLP

Dated: June 27, 2003

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Michael D. Stein Registration No. 37,240 **FORM PTO-1449**

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

1594.1258	APPLICATION NO. Unassigned
FIRST NAMED INVENTOR	Orlassigned

LIST OF REFERENCES CITED BY APPLICAN	TN.	ICA	APPL	BY	CITED	NCES	RE	REFE	OF	LIST	L
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(Use several sheets if necessary)

1594.1258	Unassigned	
FIRST NAMED INVENTOR		
Chan-Jung PARK, et al.		
FILING DATE	GROUP ART UNIT	
June 27, 2003	Unassigned	

U.S. PATENT DOCUMENTS

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EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
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FOREIGN PATENT DOCUMENTS

	DOCUMENT				OLID	TD 4 1/0	
1	NO.	DATE	COUNTRY	CLASS	SUB- CLASS	YES	LATION NO
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OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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AN	
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EXAMINER	DATE CONSIDERE

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.